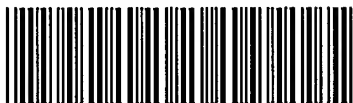


Search Notes

Application/Control No.

10/633,619

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

STELLBRINK ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	22-24,29 30,32,33 35,85-87 49	7/5/2005	SWH
347	101,108	7/5/2005	SWH
355	18	7/5/2005	SWH
358	296,302	7/5/2005	SWH
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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR